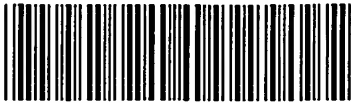


Search Notes

Application/Control No.

10/766,889

Examiner

TAN X. DINH

Applicant(s)/Patent under
Reexamination

LEE, KYUNG-GEUN

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	3/8/2007	T.D